

03500.017504.



PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: )  
MITSUTOSHI HASEGAWA, ET AL. )  
Application No.: 10/647,287 )  
Filed: August 26, 2003 )  
For: ENVELOPE, ENVELOPE )  
MANUFACTURING METHOD, )  
IMAGE DISPLAY DEVICE, AND )  
TELEVISION DISPLAY )  
Examiner: K.L. Rose  
Group Art Unit: 2822  
October 4, 2005

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

REQUEST FOR CONSIDERATION  
OF REFERENCES CITED IN FORM PTO 1449

Sir:

Attached to the Office Action of June 6, 2005 was a returned copy of a Form PTO 1449 that was filed with the Information Disclosure Statement on January 14, 2004. The documents listed under "Foreign Patent Documents" and "Other Document(s)" were not initialled, apparently because the Patent Office does not have copies of those documents in the present application. A copy of that returned Form PTO 1449 is attached hereto.

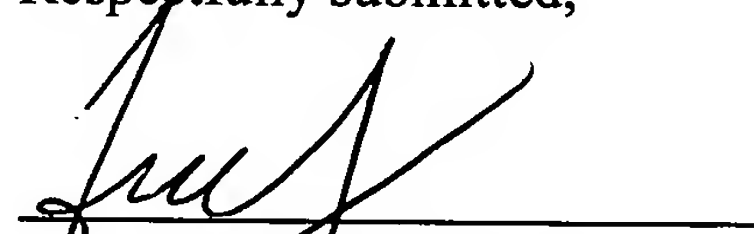
Applicants hereby provide additional copies of those documents, which are listed (but not initialled) on the enclosed Form PTO 1449. Applicants respectfully request

that Form PTO 1449 be initialed and returned by the Examiner indicating he has considered those references.

If a fee is required to have the mentioned references considered by the Examiner, please charge any such fee to Deposit Account 06-1205.

Applicants' undersigned attorney may be reached in our New York Office by telephone at (212) 218-2100. All correspondence should continue to be directed to our address listed below.

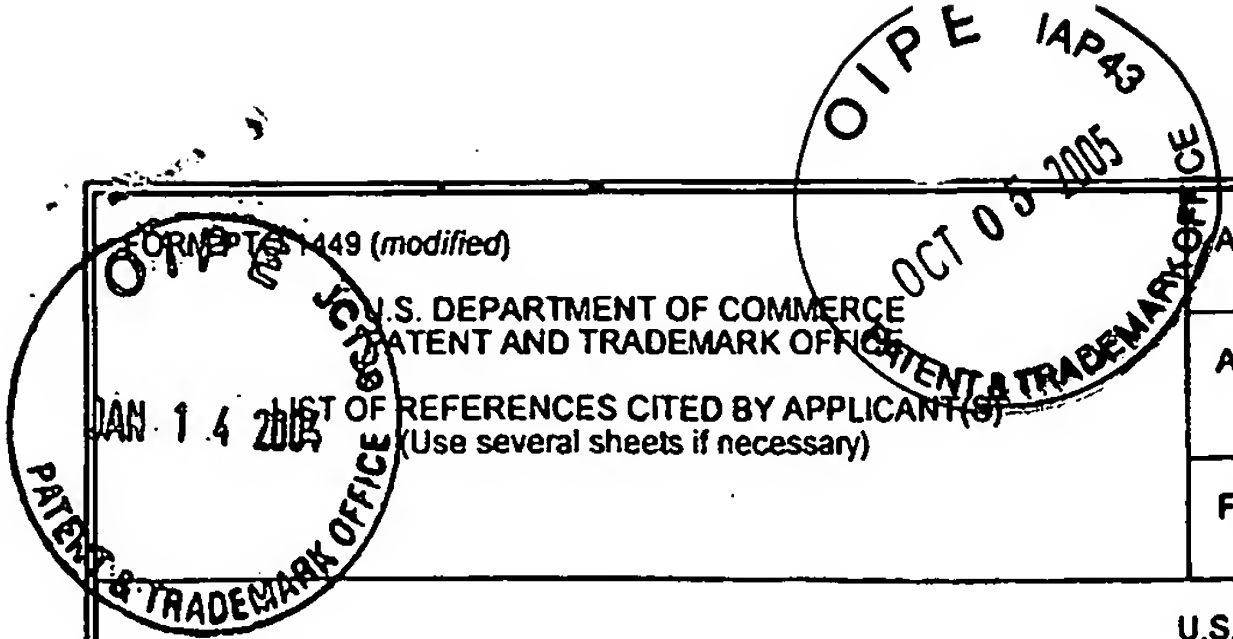
Respectfully submitted,



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NY\_MAIN 528472v1



USPTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)  
(Use several sheets if necessary)

ATTY DOCKET NO.

03500.017504

APPLICATION NO.

10/647,287

APPLICANTS

MITSUTOSHI HASEGAWA ET AL.

FILING DATE

August 26, 2003

GROUP

n/y/a

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
KR		6,060,113	05/00	Banno et al.	427	125	
		6,296,896 B1	10/01	Takahashi et al.	427	77	
		2003/0067263 A1	04/03	Tokioka et al.	313	493	08/28/02
		6,624,586 B2	09/03	Abe et al.	315	169.1	
		5,455,597	10/95	Nakamura et al.	345	75	
		5,659,329	08/97	Yamanobe et al.	345	74	
KR		6,137,218	10/00	Kaneko et al.	313	495	

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
✓	JP	7-326311	12/95	Japan			Abstract
✓	JP	8-185818	07/96	Japan			Abstract
✓	JP	9-50757	02/97	Japan			Abstract
✓	JP	9-102271	04/97	Japan			Abstract
✓	JP	2000-251665	9/00	Japan			Abstract

## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

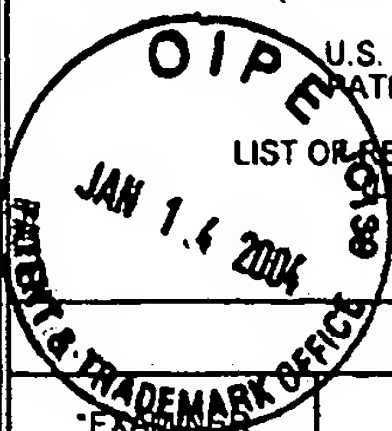
M. Hartwell et al, "Strong electron emission from patterned tin-indium oxide thin films",  
International Electron Devices Meeting 1975, Washington, D.C., Catalog No. 75, CH1023-1,  
IEDM Technical Digest, pp. 549-521.

EXAMINER

DATE CONSIDERED

4/5/05

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO 1449 (modified) <div style="text-align: center;">  </div>				ATTY DOCKET NO. <b>03500.017504</b>		APPLICATION NO. <b>10/647,287</b>	
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) <small>(Use several sheets if necessary)</small>				APPLICANT <b>mitsubishi HASEGAWA ET AL.</b>			
FILING DATE <b>August 26, 2003</b>				GROUP <b>n/y/a</b>			

U.S. PATENT DOCUMENTS							
EXAMINER'S INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
KR	6,254,449 B1	07/01	Nakanishi et al.	445	25	08/98	
	6,283,813 B1	09/01	Kaneko et al.	445	24		
	2002/0180342 A1	12/02	Yamada et al.	313	493	07/02	
	6,506,089 B2	01/03	Nakanishi et al.	445	25	02/01	
KR	2003/0058192 A1	03/03	Arai et al.	345	59	09/02	

FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
	JP 64-31332	2/89	Japan			Abstract	
	JP 6-342636	12/94	Japan			Abstract	
	JP 11-135018	05/99	Japan			Abstract	
	JPP 2001-210258	8/01	Japan			Abstract	

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)		

EXAMINER <i>[Signature]</i>	DATE CONSIDERED <b>4/5/05</b>
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